

<b>Notice of References Cited</b>	Application/Control No. 10/573,021	Applicant(s)/Patent Under Reexamination KENNETT, DAVID	
	Examiner Lindsay M. Low	Art Unit 3721	Page 1 of 3

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Application/Control No.

10/573,021

Applicant(s)/Patent Under  
Reexamination  
KENNETT, DAVID

Examiner

Lindsay M. Low

Art Unit

3721

Page 2 of 3

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	Examiner Lindsay M. Low	Art Unit 3721	Page 3 of 3

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